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INFORMATION DISCLOSURE		ATTY. DOCKET NO.	SER	UAL NO.				
STATEMENT			26822-0002 C1 10/087,527					
PTO-1449			APPLICANTS: RONG, Char	ng-Liang, ε	et al.			
			FILING DATE: 02/28/2002	GRO	OUP: 2873			
		U.S	. PATENT DOCUMENTS					
EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE		
1.7.	5,177,476 *	01/05/1993	Disanto et al.					
TT	5,872,552 *	02/16/1999	Gordon II et al.					
TT	4,655,897 *	04/07/1987	Disanto et al.		CEIVED			
TT	3,689,346 *	09/05/1972	Rowland					
TT	5,942,154 *	08/24/1999	Kim et al.	_SEP	0_9_2003			
TT	3,229,607 *	01/18/1966	Battaglia	OFFICE	OF PETITIONS			
TT	5,877,848 *	03/02/1999	Gillette et al.					
TT	5,731,860 *	03/24/1998	Harada et al.					
17	5,895,541 *	04/20/1999	Kobayashi et al.					
77	5,985,084 *	11/16/1999	Summersgill et al.					
TT	3,885,964 *	05/27/1975	Nacci					
11	4,741,604 *	05/03/1988	Kornfeld					
TT	5,200,120 *	04/06/1993	Sakai					
11	6,113,836*	09/05/2000	Sakai et al.					
TT	6,400,492 *	06/04/2002	Morita et al.					
. 17	6,512,626 *	01/28/2003	Schmidt					
79	6,514,328 *	02/04/2003	Katoh et al.					
77	5,589,100 *	12/31/1996	Grasso et al.					
14	5,835,174 *	11/10/1998	Clikeman et al.					
74	5,976,405 *	11/02/1999	Clikeman et al.					
19	6,037,05 *	03/14/2000	Clikeman et al.	<u> </u>				
77	3,908,052 *	09/23/1975	Sanders	<u></u>				
TT	5,274,481 *	12/28/1993	Kim	-				
TT	5,739,889 *	04/14/1998	Yamada et al.	-		<u></u>		
TT	6,120,946 * .	9/19/2000	Johnson et al.	-				
11	6,166,797 *	12/26/2000	Bruzzone et al.					
77	5,843,333 *	12/01/1998	Hakemi					
77	5,460,688 *	10/24/1995	Disanto et al					
TT	3,892,568	07/01/1975	Ota et al.					
	·			·				

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INFORMATION DISCLOSURE STATEMENT PTO-1449		ATTY. DOCKET NO.						
		26822-0002 C1 10/087,527						
		APPLICANTS: RONG, Chang-Liang, et al.						
			FILING DATE: 02/28/2002	GROUP: 2873				
		U.S	. PATENT DOCUMENTS					
EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CL.	ASS	SUBCLASS	FILING	G DATE
TT	6,191,250 *	02/20/2001	Aida et al.	-				
TT	4,190,352 *	02/26/1980	Bruning					
TT	4,924,257 *	05/08/1990	Jain	-		ECEIVE	U _	-
TT	5,285,236 *	02/08/1994	Jain	_	_ S	EP <u>09</u> 200	3 -	
TT	5,652,645 *	07/29/1997	Jain	_	OFFI	CE OF PETITIO	DAYS	_
TT	5,398,041 *	03/14/1995	Hyatt		_			_
TT	5,432,526 *	07/11/1995	Hyatt	-	_		-	
TT	5,995,190 *	11/30/1999	Nagae et al.	-	_			
TT	5,956,112 *	09/21/1999	Fujimori et al.	-				
TT	5,450,220 *	09/12/1995	Onishi et al.	-				
17	6,018,383 *	01/25/2000	Dunn et al∠	_				
77	2001/0009352 *	07/26/2001	Moore				-	
77	2002/0029969 *	03/14/2002	Yager et al					
TT	2002/0196525 *	12/26/2002	Chen et al.	_		-		
77	2002/0018043 *	02/14/2002	Nakanishi	_	_			
15	2002/0188053 *	12/12/2002	Zang et al.	-	_			
77	20020126249 *	12/05/2002	Chan-Park, et al.	_	~			
77	20020126249 *	09/12/2002	Liang, et al.	_				
FOREIGN PATENT DOCUMENTS								
EXAMINER'S	PATENT NO.	DATE	COUNTRY (Inventor)	CL	ASS	SUBCLASS	TRANS	LATION
INITIALS				ļ			YES	NO
TT	199 27 359.6 *	Pub. Date 12/21/00	Germany ¹ (Schmidt, F. G.)				□.	×
TT	2,340,68 *	Nat'l Entry Dt 2/14/2001	Canada (Schmidt, F. G.)		_		\boxtimes	
TT	EP 1065553 *	Pub Date 01/03/2001	Europe (Ogawa)	_				
TT	EP 0990942 *	Pub Date 04/05/2000	Europe (Yamanaka)	-				
TT	EP 1195603 *	Pub Date 04/10/2002	Europe (Kawai)		_			
TT	JP 6242423 *	Pub Date 09/02/1994	Japan (Nakai Yuichi) (English abstract included)					

¹ See English counterparts US Patent No. 6,512,626 or Canadian Patent Application No. 2,340,683. Applicant would be happy to obtain a direct translation of the document if desired.

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						SHEET	1 3 OF 4		
INFORMATION DISCLOSURE STATEMENT			ATTY. DOCKET NO.	SE	SERIAL NO.				
			26822-0002 C1 10/087,527						
PTO-1449			APPLICANTS: RONG, Chang-Liang, et al.						
			FILING DATE: 02/28/2002	GROUP: 2873					
		FORI	EIGN PATENT DOCUMENTS						
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY (Inventor)	CLASS	SUBCLASS	TRANS	LATION		
77.	JP 1-86116 *	Pub Date 01/26/1990	Japan (Seiichiro) (English abstract included)				×		
4	JP 60-205452 *	Pub Date 10/17/1985	Japan (Hisanori) (English abstract included)	REC	EIVED		\boxtimes		
11	JP 2000 035677	Pub Date 02/02/2000	Japan (English abstract included)		9 2003		Ø		
77	JP 2000 075497	Pub Date 03/14/2000	Japan		PETITIONS		⊠		
79	JP 2001 042118 *	Pub Date 02/16/2001	Japan (English abstract included)	-			\boxtimes		
77	JP 2001 056653 *	Pub Date 02/27/2001	Japan (Hayakawa) (English abstract included)		_		\boxtimes		
77	JP 02284126 *	Pub Date 11/21/1990	Japan (Oshiro) (English abstract included)	-			\boxtimes		
19	WO 97/04398 *	Pub Date 02/06/1997	PCT (Jacobson)	-					
17	WO 00/77571 *	Pub Date 12/21/00	PCT ¹ (Schmidt, F. G.)				\boxtimes		
TT	WO 01/67170 *	Pub Date 09/13/2001	PCT (Liang et al.)						
TT	WO 99/08151 *	Pub Date 02/18/1999	PCT (Bruzzone et al.)						
TT	WO 00/03291 *	Pub Date 01/20/2000	PCT (Jacobson et al.)						
TT	WO 02/01281 *	Pub Date 01/03/2002	PCT (Liang et al.)						
77	WO 99/53373 *	Pub Date 10/21/1999	PCT (Drzaic)						
	OTHER DO	CUMENTS (I	ncluding Author, Title, Date, Pe	ertinent P	ages, Etc.)				
T.T	* Drzaic, P.S., "	Liquid Crystal	Dispersions", The PDLC Paradig	gm, pp 1-9	, (1995)				
1	* Singer, B. "X-	Y Addressable	Electrophoretic Display", Proc. S	SID-18 (3/-	1): 255-266 (1977	7)			
	* Kazlas, P. et al Applicances" SI		roencapsulated Electorphoretic A 2-155 (2001)	ctive Matr	ix Display for Inf	formation	1		
·	* Bryning et al.,	* Bryning et al., "Reverse-Emulsion Electrophoretic Display (REED)" SID 98 Digest 1018-1021 (1998)							
* Swanson et al., "High Performance Electrophoretic Displays" SID 00 Digest 29-31 (2000) * Inoue, S. et al., "High Resolution Microencapsulated Electrophoretic Display (EPD) Driven by Poly-TFTs With Four-Level Grayscale" IEEE Transactions on Electron Devices 49(8):1532-1539 (2002)									
	* Matsuda Y. "Newly designed, high resolution, active matrix addressing in plane EPD" <i>IDW 02 EP2-3</i> 1341-1344 (2002)								

¹See English counterparts US Patent No. 6,512,626 or Canadian Patent Application No. 2,340,683. Applicant would be happy to obtain a direct translation of the document if desired.

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INFORMATION DISCLOSURE STATEMENT PTO-1449		ATTY. DOCKET NO.	SERIAL NO.			
		26822-0002 C1	10/087,527			
		APPLICANTS: RONG, Chang-Liang, et al.				
		FILING DATE: 02/28/2002	GROUP: 2873			
	OTHER DOCUMENTS (Including Author, Title, Date, Pertine	ent Pages, Etc.)			
TT	· ·	Including Author, Title, Date, Pertinent Pages, Etc.) Electrophoretic Displays" Proc. of SID 18:243-254 (1977)				
77	* Kishi, E et al, "5.1 Development of In-Plane EPD", Canon Research Center, SID Digest, 2000, pp 24-27					
77	USSN 09/606,654, "Manufacturing Process for Electrophoretic Display", filed 6/28/2000 (copy provided upon request)					
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

*If an asterisk is placed beside the reference number, a copy is not provided because the reference was previously cited by or submitted to the PTO in a prior application that is identical in the statement and relied upon for an earlier filing date under 35 U.S.C. §120. 37 C.F.R. §1.98 (d).

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INFORMATION DISCLOSURE		ATTY. DOCKET NO. SERIAL NO.						
STATEMENT PTO-1449			26822-0002 C1 10/087,527					
			APPLICANTS: RONG, Chang-Liang, et al.					
			FILING DATE: 02/28/2002 GROUP: 2873			OUP: 2873		
		U.S	S. PATENT DOCUMENTS					
EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	IE CLASS SUBCLASS		SUBCLASS	FILING	G DATE
T.T.	2002/0182544	12/05/02	Chan-Park, et al.					
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		FOR	EIGN PATENT DOCUMENTS	<u> </u>				
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY (Inventor)	CLASS		SUBCLASS	TRANSLATION	
INTIALS							YES	NO
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	OTHER DO	CUMENTS (Including Author, Title, Date, F	Pertine	nt Pa	ges, Etc.)		
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Tuyen Tra		DATE CONSIDERED 5/5/200	4					

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